

SN54100 . . . J OR W PACKAGE
SN54100 . . . J OR N PACKAGE
(TOP VIEW)

logic

FUNCTION TABLE
(Each Latch)

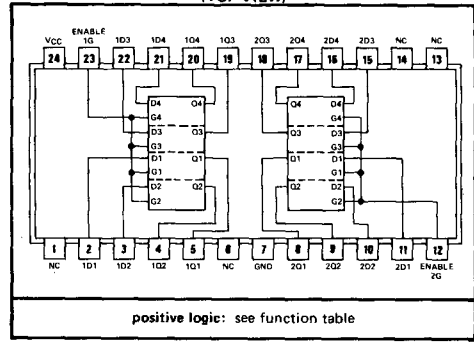
INPUTS		OUTPUTS	
D	G	Q	\bar{Q}
L	H	L	H
H	H	H	L
X	L	Q_0	\bar{Q}_0

H = high level, X = irrelevant
 Q_0 = the level of Q before the high-to-low transition of G

description

These latches are ideally suited for use as temporary storage for binary information between processing units and input/output or indicator units. Information present at a data (D) input is transferred to the Q output when the enable (G) is high and the Q output will follow the data input as long as the enable remains high. When the enable goes low, the information (that was setup at the data input at the time the transition occurred) is retained at the Q output until the enable is permitted to go high.

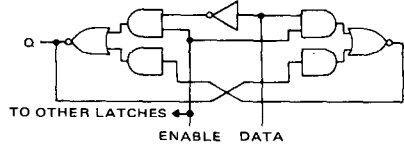
These circuits are completely compatible with all popular TTL or DTL families. All inputs are diode-clamped to minimize transmission-line effects and simplify system design. Typical power dissipation is 40 milliwatts per latch. The SN54100 is characterized for operation over the full military temperature range of -55° to 125°C ; the SN74100 is characterized for operation from 0°C to 70°C .



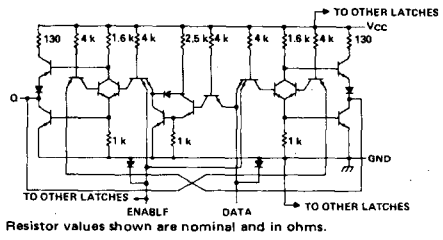
positive logic: see function table

NC—No internal connection

functional block diagram (each latch)



schematic (each latch)



Resistor values shown are nominal and in ohms.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	5.5 V
Intermitter voltage (see Note 2)	5.5 V
Operating free-air temperature range: SN54100	-55°C to 125°C
SN74100	0°C to 70°C
Storage temperature range	-65°C to 150°C

- NOTES: 1. Voltage values, except intermitter voltage, are with respect to network ground terminal.
2. This is the voltage between two emitters of a multiple-emitter input transistor. For this circuit, this rating applies between the enable and D inputs of any latch.

TYPES SN54100, SN74100

8-BIT BISTABLE LATCHES

REVISED OCTOBER 1976

recommended operating conditions

	SN54100			SN74100			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}	-400			-400			μ A
Low-level output current, I_{OL}	16			16			mA
Width of enabling pulse, t_W	20			20			ns
Setup time, t_{SU}	20			20			ns
Hold time, t_H	5			5			ns
Operating free-air temperature, T_A	-55			125			$^{\circ}$ C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
V_{IH}	High-level input voltage		2			V
V_{IL}	Low-level input voltage				0.8	V
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$			-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -400 \mu\text{A}$	2.4	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 16 \text{ mA}$		0.2	0.4	V
I_I	Input current at maximum input voltage	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1	mA
I_{IH}	High-level input current	D input			80	μ A
		G input			320	
I_{IL}	Low-level input current	D input			-3.2	mA
		G input			-12.8	
I_{OS}	Short-circuit output current‡	$V_{CC} = \text{MAX}$	SN54100	-20	-57	mA
			SN74100	-18	-97	
I_{CC}	Supply current	$V_{CC} = \text{MAX},$ See Note 3	SN54100	64	92	mA
			SN74100	64	106	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$.

§ Not more than one output should be shorted at a time.

NOTE 3: I_{CC} is tested with all inputs grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

PARAMETER‡	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	D	Q	$C_L = 15 \text{ pF},$ $R_L = 400 \Omega,$ See Note 4		16	30	ns
t_{PHL}					14	25	
t_{PLH}	G	Q			16	30	ns
t_{PHL}					7	15	

‡ t_{PLH} = propagation delay time, low-to-high-level output

‡ t_{PHL} = propagation delay time, high-to-low-level output

NOTE 4: Test circuit and voltage waveforms are the same as those shown for the '75, '77, 'L75, and 'L77 on page 7-40.